

<b>Notice of References Cited</b>	Application/Control No. 10/670,356	Applicant(s)/Patent Under Reexamination HATANO ET AL.	
	Examiner Tuan H. Nguyen	Art Unit 2813	Page 1 of 1

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	C	US-5,815,494	09-1998	Yamazaki et al.	372/25
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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